

Notice of References Cited			Application/Control No. 09/315,068	Applicant(s)/Patent Under Reexamination HAYAKAWA ET AL.	
			Examiner Jeffrey N Zahn <i>H. Zahn 6/1/2002</i>	Art Unit 2828	Page 1 of 1

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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